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- Operates With Single 5-V Power Supply
- LinBiCMOS[™] Process Technology
- Two Drivers and Two Receivers
- ±30-V Input Levels
- Low Supply Current . . . 8 mA Typical
- Meets or Exceeds TIA/EIA-232-F and ITU Recommendation V.28
- Designed to be Interchangeable With Maxim MAX232
- ESD Protection Exceeds JESD 22

 2000-V Human-Body Model (A114-A)
 - Applications TIA/EIA-232-F Battery-Powered Systems Terminals Modems Computers
- Package Options Include Plastic Small-Outline (D, DW, NS) Packages and Standard Plastic (N) DIPs

description

The MAX232 device is a dual driver/receiver that includes a capacitive voltage generator to supply EIA-232 voltage levels from a single 5-V supply. Each receiver converts EIA-232 inputs to 5-V TTL/CMOS levels. These receivers have a typical threshold of 1.3 V and a typical hysteresis of 0.5 V, and can accept ±30-V inputs. Each driver converts TTL/CMOS input levels into EIA-232 levels. The driver, receiver, and voltage-generator functions are available as cells in the Texas Instruments LinASIC[™] library.

The MAX232 is characterized for operation from 0° C to 70° C. The MAX232I is characterized for operation from -40° C to 85° C.

AVAILABLE OF HONS							
	PACKAGED DEVICES						
TA	SMALL OUTLINE (D, NS)	SMALL OUTLINE (DW)	PLASTIC DIP (N)				
0°C to 70°C	MAX232D MAX232NS	MAX232DW	MAX232N				
–40°C to 85°C	MAX232ID	MAX232IDW	MAX232IN				

AVAILABLE OPTIONS

The D and DW packages are available taped and reeled by adding an R to the part number (i.e., MAX232DR). The NS package is only available taped and reeled.



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D, DW, N, OR NS PACKAGE (TOP VIEW)							
C1+ [1	σ	16] V _{CC}			
V _{S+} [2		15] GND			
C1- [3		14] T1OUT			
C2+ [4		13] R1IN			
C2- [5		12] R1OUT			
V _{S-} [6		11] T1IN			
T2OUT [7		10] T2IN			
R2IN [8		9] R2OUT			

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Input supply voltage range, V _{CC} (see Note 1))	
Positive output supply voltage range, V _{S+}		$V_{CC} = 0.3 \text{ V to } 15 \text{ V}$
Negative output supply voltage range, V_{S-} .		
Input voltage range, V _I : Driver		$\dots \dots -0.3 \text{ V to V}_{CC} + 0.3 \text{ V}$
Receiver		$\dots \dots \pm 30 \text{ V}$
Output voltage range, VO: T1OUT, T2OUT .		$\dots V_{S-} - 0.3 \text{ V to } V_{S+} + 0.3 \text{ V}$
R1OUT, R2OUT		$\dots -0.3 \text{ V to V}_{CC} + 0.3 \text{ V}$
Short-circuit duration: T1OUT, T2OUT		Ūnlimited
Package thermal impedance, θ_{JA} (see Note 2	2): D package	
		57°C/W
	N package	67°C/W
	NS package	64°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		
Storage temperature range, T _{stg}		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network ground terminal.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions

			MIN	NOM	MAX	UNIT
V _{CC}	V _{CC} Supply voltage		4.5	5	5.5	V
VIH	V _{IH} High-level input voltage (T1IN,T2IN)		2			V
VIL	Low-level input voltage (T1IN, T2IN)				0.8	V
R1IN, R2IN	Receiver input voltage				±30	V
т _А	Operating free-air temperature	MAX232	0		70	°C
		MAX232I	-40		85	U



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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT	
Vou High level output voltage		$R_L = 3 k\Omega$ to GND		5	7		V	
Vон	High-level output voltage	R1OUT, R2OUT	I _{OH} = -1 mA		3.5			v
Vai	1	T1OUT, T2OUT	$R_L = 3 k\Omega$ to GND)		-7	-5	V
VOL	Low-level output voltage [‡]	R1OUT, R2OUT	I _{OL} = 3.2 mA				0.4	v
VIT+	Receiver positive-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	$T_A = 25^{\circ}C$		1.7	2.4	V
VIT–	Receiver negative-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	T _A = 25°C	0.8	1.2		V
Vhys	Input hysteresis voltage	R1IN, R2IN	$V_{CC} = 5 V$		0.2	0.5	1	V
ri	Receiver input resistance	R1IN, R2IN	V _{CC} = 5,	$T_A = 25^{\circ}C$	3	5	7	kΩ
ro	Output resistance	T1OUT, T2OUT	$V_{S+} = V_{S-} = 0,$	$V_{O} = \pm 2 V$	300			Ω
IOS§	Short-circuit output current	T1OUT, T2OUT	V _{CC} = 5.5 V,	Λ ^O = 0		±10		mA
IIS	Short-circuit input current	T1IN, T2IN	V _I = 0				200	μA
ICC	Supply current		$V_{CC} = 5.5 V,$ $T_A = 25^{\circ}C$	All outputs open,		8	10	mA

 [†] All typical values are at V_{CC} = 5 V, T_A = 25°C.
 [‡] The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels only.

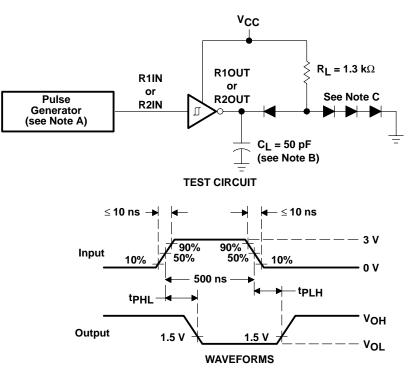
\$ Not more than one output should be shorted at a time.

switching characteristics, V_{CC} = 5 V, T_A = 25° C

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
^t PLH(R)	Receiver propagation delay time, low- to high-level output	See Figure 1	500		ns
^t PHL(R)	Receiver propagation delay time, high- to low-level output	See Figure 1	500		ns
SR	Driver slew rate	$R_L = 3 k\Omega$ to 7 kΩ, See Figure 2		30	V/µs
SR(tr)	Driver transition region slew rate	See Figure 3	3		V/µs



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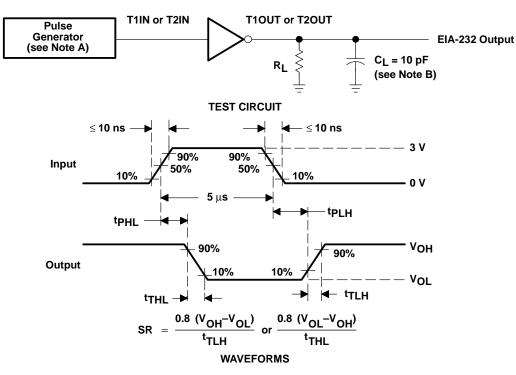
PARAMETER MEASUREMENT INFORMATION

- NOTES: A. The pulse generator has the following characteristics: Z_{O} = 50 Ω , duty cycle \leq 50%.
 - B. CL includes probe and jig capacitance.
 - C. All diodes are 1N3064 or equivalent.

Figure 1. Receiver Test Circuit and Waveforms for tPHL and tPLH Measurements



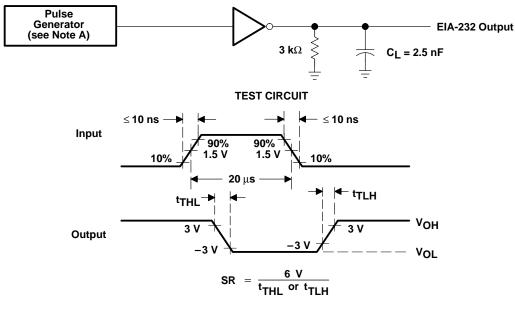
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PARAMETER MEASUREMENT INFORMATION

NOTES: A. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, duty cycle $\leq 50\%$. B. C_L includes probe and jig capacitance.

Figure 2. Driver Test Circuit and Waveforms for $t_{\mbox{PHL}}$ and $t_{\mbox{PLH}}$ Measurements (5- $\!\mu\mbox{s}$ input)



WAVEFORMS

NOTE A: The pulse generator has the following characteristics: Z_{O} = 50 Ω , duty cycle \leq 50%.

Figure 3. Test Circuit and Waveforms for t_{THL} and t_{TLH} Measurements (20- μ s input)



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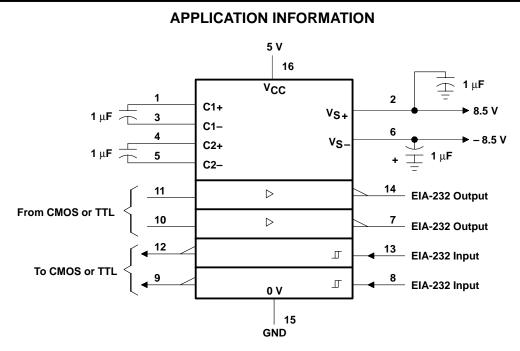


Figure 4. Typical Operating Circuit



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